Se	Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/829,163	WECK ET AL.
Examiner	Art Unit
PHILIPPE S. DERAKSHANI	3754

	SEAD	CHED	
	JLAN	CITED	,
Class	Subclass	Date	Examiner
222	382 377 464.7	10/15/2005	PD

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH (INCLUDING SEAF	NOTES RCH STRATEG	iY)
	DATE	EXMR
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